



<p><b>Search Notes</b></p> 	<p>Application/Control No.</p> <p>10642667</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>SATOH, YOSHIHIRO</p>
	<p>Examiner</p> <p>Novacek, Christy L</p>	<p>Art Unit</p> <p>2822</p>

Notes	Date	Examiner
-------	------	----------

EAST and WEST Search	5/25/06	CN
----------------------	---------	----

U.S. Patent and Trademark Office	Part of Paper No.: 20060525
----------------------------------	-----------------------------

*G*

<b><i>Interference S arched</i></b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10642667	SATOH, YOSHIHIRO
	Examiner Novacek, Christy L	Art Unit 2822


Class	SubClass	Date	Examiner
-------	----------	------	----------

PGPUB text search - see  
interference search printout

5/25/06

CN

U.S. Patent and Trademark Office	Part of Paper No.:	20060525
----------------------------------	--------------------	----------

<p style="text-align: center;"><b>Searched</b></p> 	Application/Control No.  10642667	Applicant(s)/Patent Under Reexamination  SATOH, YOSHIHIRO
	Examiner Novacek, Christy L	Art Unit 2822

Class	SubClass	Date	Examiner
438	671	5/25/06	CN
438	945	5/25/06	CN
438	946	5/25/06	CN
438	597	5/25/06	CN
U.S. Patent and Trademark Office		Part of Paper No.:	20060525